

Notice of References Cited	Application/Control No. 10/564,571		Applicant(s)/Patent Under Reexamination TIMMER, JAN	
	Examiner John M. Corbett		Art Unit 2882	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,035,012	03-2000	Hsieh, Jiang	378/4
*	C	US-6,266,388	07-2001	Hsieh, Jiang	378/8
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	De Man et al., Metal Streak Artifacts in X-ray Computed Tomography: A Simulation Study, IEEE Nuclear Science Symposium, 1998, Volume 3, pages 1860-1865
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.